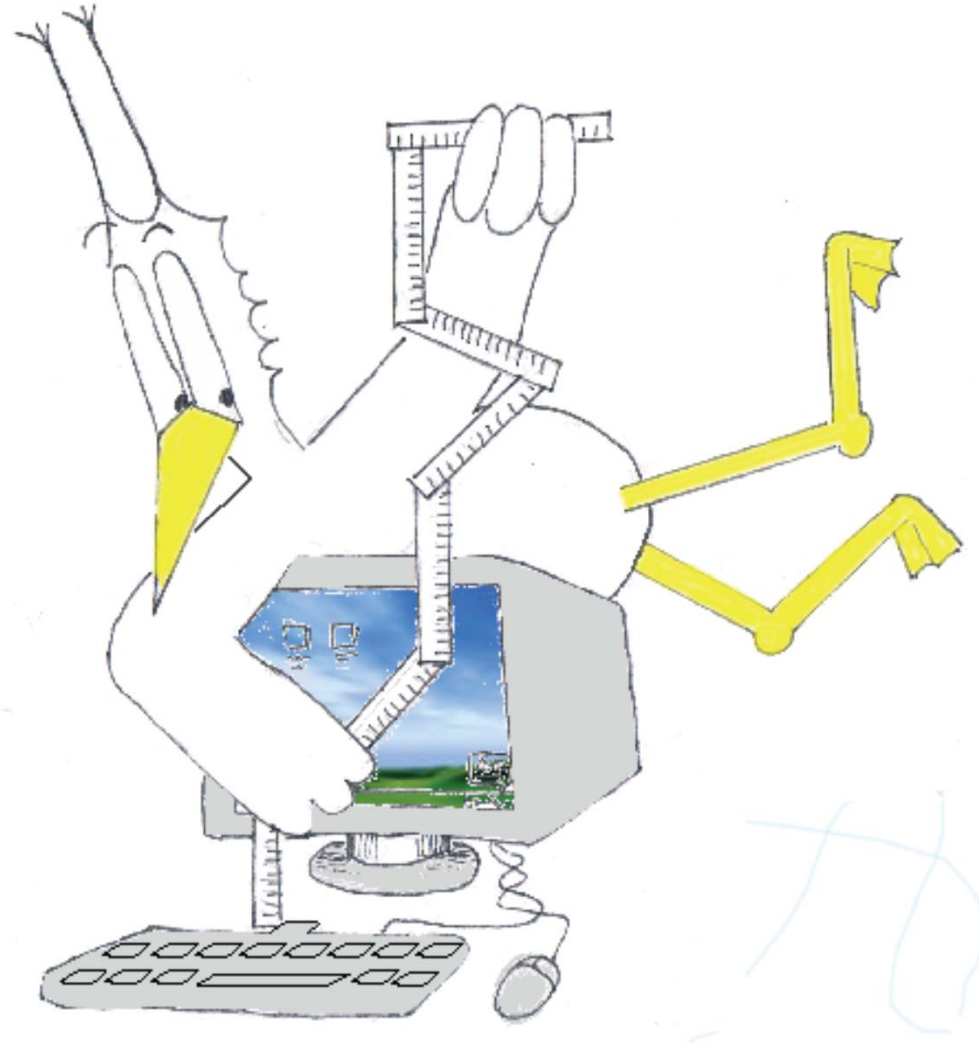


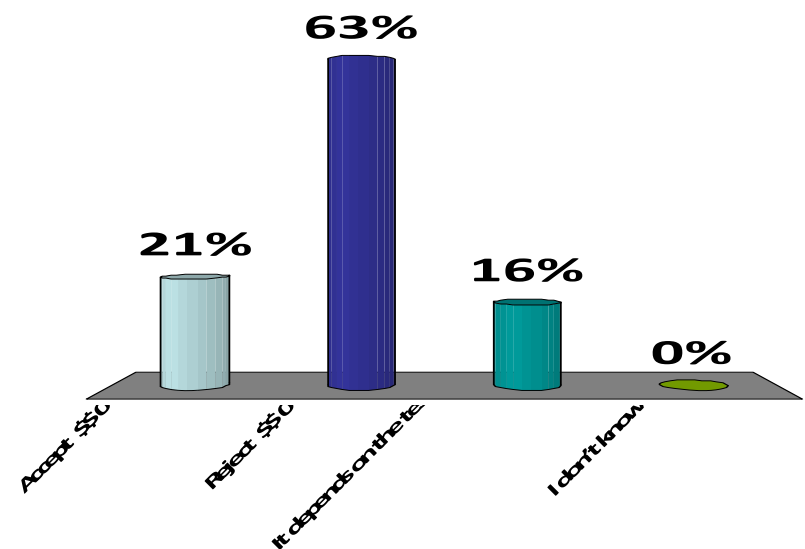
# Bonus Tests

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2015



If the data is in the critical region we...

- A. Accept  $H_0$
- B. Reject  $H_0$
- C. It depends on the test
- D. I don't know

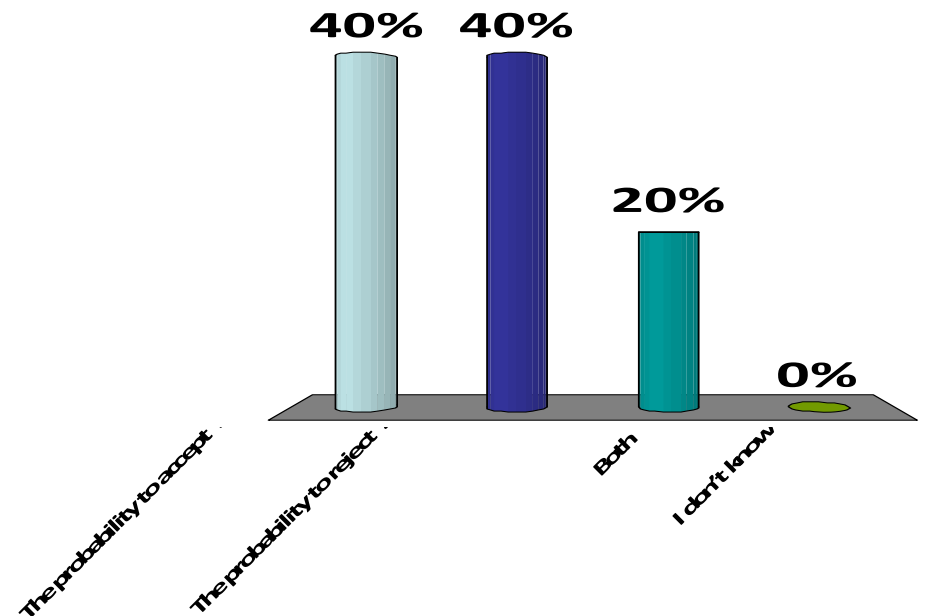


# Solution

Answer B, by definition of the critical region

Saying that a test is of size 5% means that...

- A. The probability to accept  $H_0$  when it does not hold is  $\leq 0.05$
- B. The probability to reject  $H_0$  when it holds is  $\leq 0.05$
- C. Both
- D. I don't know

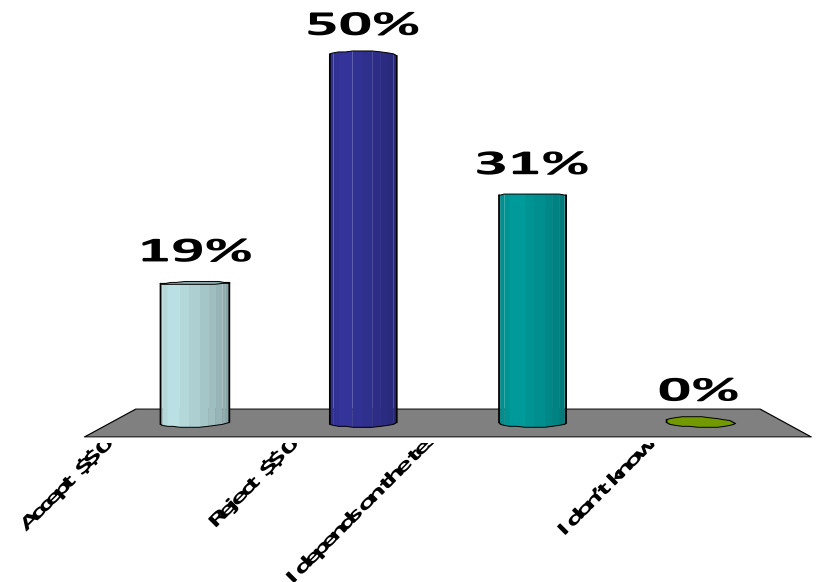


# Solution

Answer B, by definition of the size of a test.

- A. Accept  $H_0$
- B. Reject  $H_0$
- C. I depends on the test
- D. I don't know

If the  $p$  –value  
of a test is small  
we...

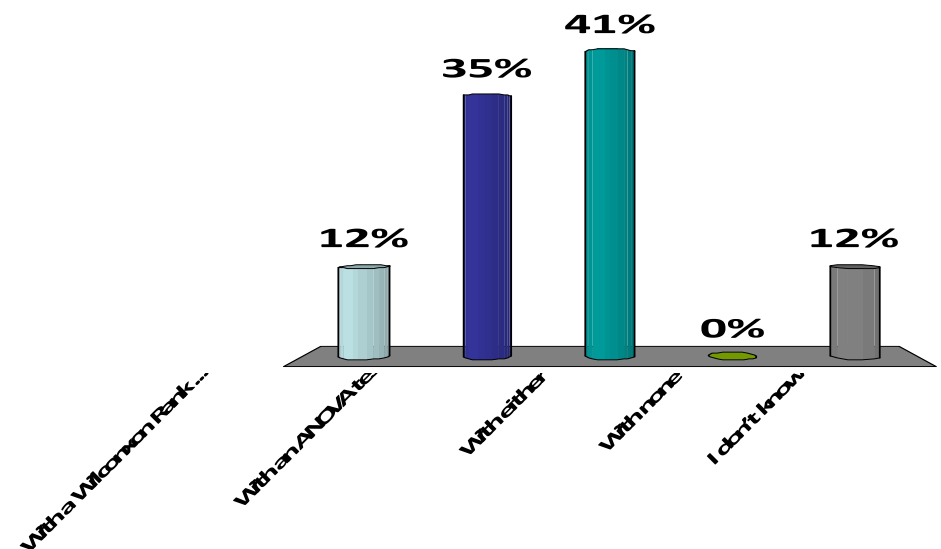


# Solution

Answer B, by definition of the p-value

We have a collection of random variables  $X_i, Y_i$  which correspond to non paired simulation results with configuration 1 or 2. How can you test whether the configuration plays a role or not ?

- A. With a Wilcoxon Rank Sum test
- B. With an ANOVA test
- C. With either
- D. With none
- E. I don't know





# Solution

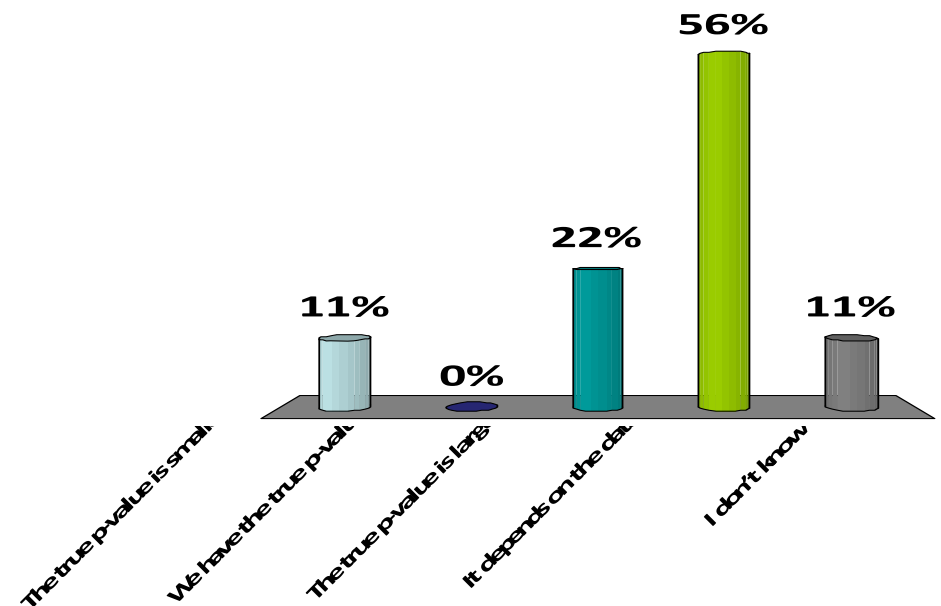
Answer C

A is robust and can be used if we can ensure that the simulation runs are independent and that the two distributions differ by a location shift, i.e. have same variance

B is applicable if, in addition,  $X_i$  and  $Y_i$  can be assumed gaussian with same variance

**We test whether a distribution is gaussian using a Kolmogorov-Smirnov test against the fitted distribution. We obtain a  $p$  –value**

- A. The true  $p$ -value is smaller
- B. We have the true  $p$ -value
- C. The true  $p$ -value is larger
- D. It depends on the data
- E. I don't know



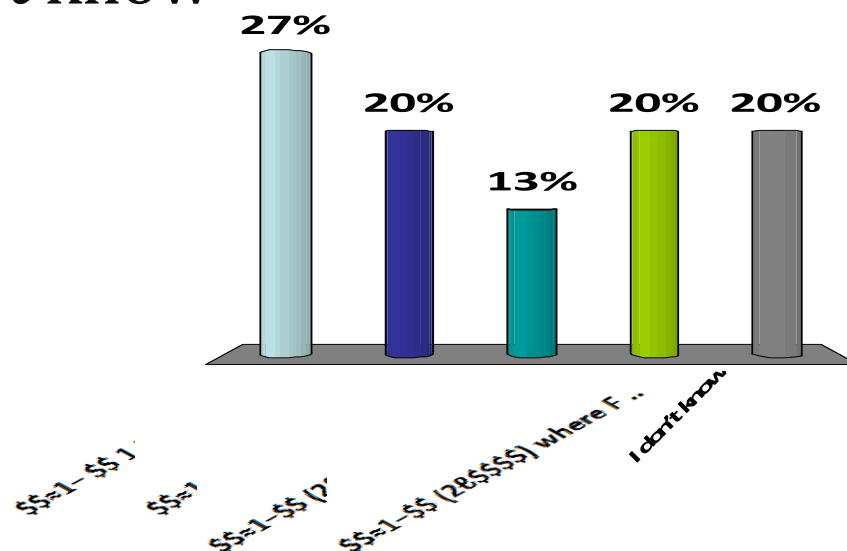
# Solution

## Answer A

The KS test applies if we are testing against a fixed, non fitted distribution  $F$ . By using a fitted distribution, we are biasing the test, we are making it more likely than should be to accept the distribution  $F$ , i.e. to accept  $H_0$ . The p-value is higher when we accept  $H_0$ , i.e. we are overestimating the p-value.

We have two data sets  $X_i$  and  $Y_j$  believed to be iid and from one exponential distribution each. We test whether they come from the same distribution and make a likelihood ratio test. The log likelihood ratio statistic is  $lrs$ . The p-value is...

- A.  $p \approx 1 - \chi_1^2(2lrs)$
- B.  $p \approx 1 - \chi_2^2(2lrs)$
- C.  $p \approx 1 - F(2lrs)$  where F is the CDF of the standard exponential distribution
- D.  $p \approx 1 - F(2lrs)$  where F is the CDF of the standard Laplace distribution
- E. I don't know



# Solution

1. The log-likelihood is  $m \log \lambda - \lambda \sum_i x_i + n \log \mu - \mu \sum_j y_j$   
where  $i = 1 \dots m, j = 1 \dots n$ ,  $\lambda$  [resp.  $\mu$ ] is the parameter of the  
expo distrib of  $X_i$  [resp.  $Y_j$ ]

2. Under  $H_0: \lambda = \mu$ , max is for  $\lambda^{-1} = \mu^{-1} = \frac{\sum_i x_i + \sum_j y_j}{m+n}$

$$\ell_0 = (m+n) \log \left( \frac{m+n}{\sum_i x_i + \sum_j y_j} \right) - m - n$$

3. Under  $H_1$ , max is for  $\lambda^{-1} = \frac{\sum_i x_i}{m}$ ,  $\mu^{-1} = \frac{\sum_j y_j}{n}$

$$\ell_1 = m \log \left( \frac{m}{\sum_i x_i} \right) + n \log \left( \frac{n}{\sum_j y_j} \right) - m - n$$

$$lrs = \ell_1 - \ell_0$$

4. The order is  $p = 2 - 1 = 1$ ,  $p \approx 1 - \chi_1^2(2lrs)$

Answer A